

**Search Notes**

Application/Control No.

10/531,050

Examiner

David Mis

Applicant(s)/Patent under  
Reexamination

HIRANO ET AL.

Art Unit

2817

**SEARCHED**

| Class | Subclass | Date      | Examiner |
|-------|----------|-----------|----------|
| 332   | 103-105  | 9/28/2006 | DM       |
| 331   | 16       |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |
|       |          |           |          |

**INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE | EXMR |
|--|------|------|
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |
|  |      |      |